

<b>Notice of References Cited</b>	Application/Control No. 10/557,481		Applicant(s)/Patent Under Reexamination HECKMEIER ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0278850	12-2006	Czanta et al.	252/299.61
*	B	US-2007/0001149	01-2007	Manabe et al.	252/299.66
*	C	US-2007/0170395	07-2007	Ichinose et al.	252/299.61
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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